

Notice of References Cited	Application/Control No. 10/021,176	Applicant(s)/Patent Under Reexamination HAYDER ET AL.	
	Examiner Frederick J. Parker	Art Unit 1762	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,200,635	03-2001	Kwok, Kui-Chiu	427/286
	B	US-			
	C	US-			
	D	US-			
	E	US-			
	F	US-			
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FOREIGN PATENT DOCUMENTS

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	N					
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NON-PATENT DOCUMENTS

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